

UP01113

Silicon PNP epitaxial planar type

For digital circuits

■ Features

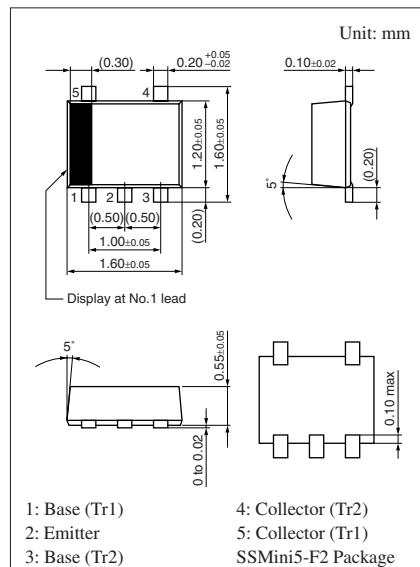
- Two elements incorporated into one package
(Transistors with built-in resistor)
- Reduction of the mounting area and assembly cost by one half

■ Basic Part Number

- UNR1113 \times 2

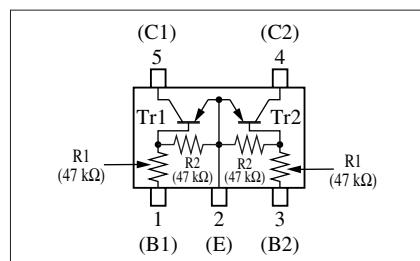
■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	V_{CBO}	-50	V
Collector-emitter voltage (Base open)	V_{CEO}	-50	V
Collector current	I_C	-100	mA
Total power dissipation	P_T	125	mW
Junction temperature	T_j	125	°C
Storage temperature	T_{stg}	-55 to +125	°C



Marking Symbol: 7L

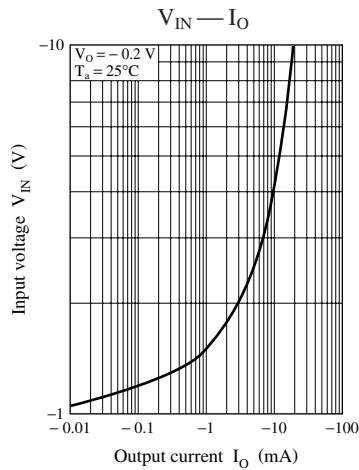
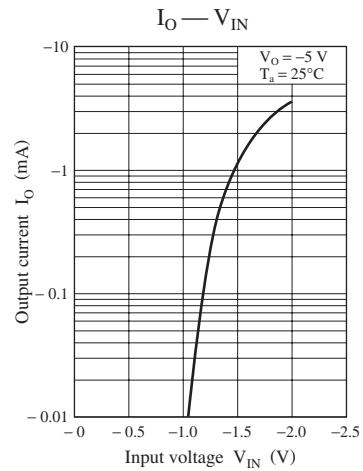
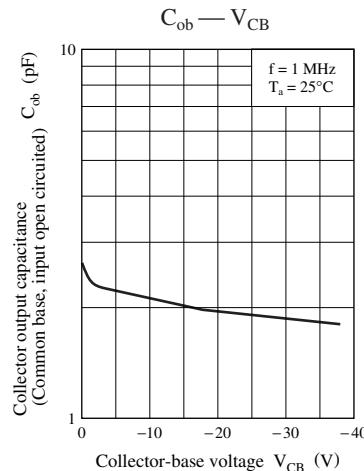
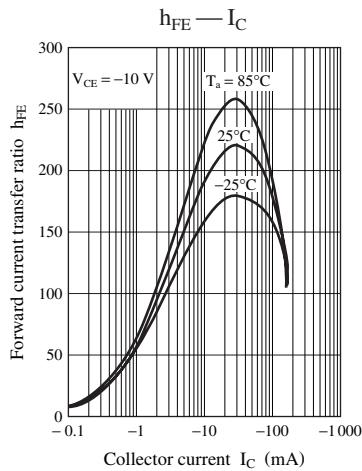
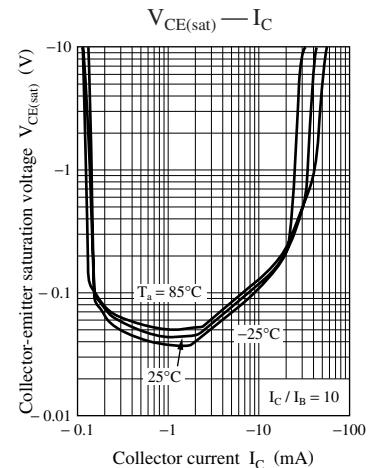
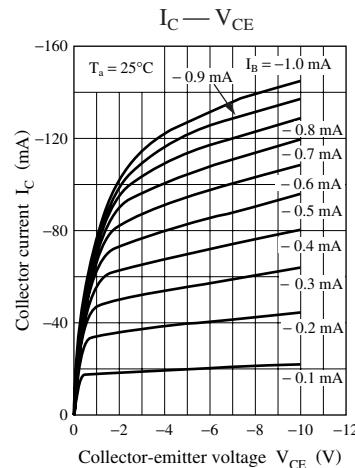
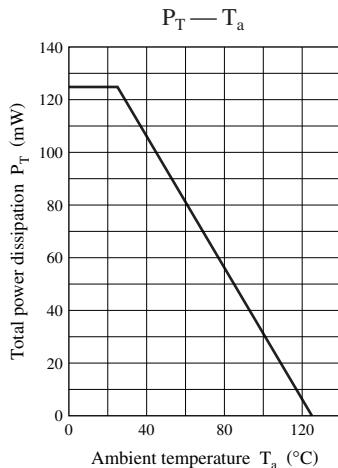
Internal Connection



■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	V_{CBO}	$I_C = -10 \mu A, I_E = 0$	-50			V
Collector-emitter voltage (Base open)	V_{CEO}	$I_C = -2 mA, I_B = 0$	-50			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -50 V, I_E = 0$		-0.1		μA
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = -50 V, I_B = 0$		-0.5		μA
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = -6 V, I_C = 0$		-0.1		mA
Forward current transfer ratio	h_{FE}	$V_{CE} = -10 V, I_C = -5 mA$	80			—
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -10 mA, I_B = -0.3 mA$		-0.25		V
Output voltage high-level	V_{OH}	$V_{CC} = -5 V, V_B = -0.5 V, R_L = 1 k\Omega$	-4.9			V
Output voltage low-level	V_{OL}	$V_{CC} = -5 V, V_B = -3.5 V, R_L = 1 k\Omega$		-0.2		V
Input resistance	R_1		-30%	47	+30%	$k\Omega$
Resistance ratio	R_1 / R_2		0.8	1.0	1.2	—
Transition frequency	f_T	$V_{CB} = -10 V, I_E = 1 mA, f = 200 MHz$		80		MHz

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.



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